



NOTES:

1. OPERATION WAVELENGTH: 200 nm-2.1 μm
2. CLEAR APERTURE (S1,S2,S3) : >70%CA
3. ANGLE TOLERANCE: <3 arcmin
4. SURFACE QUALITY (S1,S2,S3) : 40/20 (S/D)
5. SURFACE FLATNESS (S1,S2,S3) : λ/10@632.8 nm
6. CHAMFER: <0.2 mm, 45°
7. COATING (S1,S2,S3) : UNCOATED
8. OTHER SURFACES: FINE GROUND

DRAWING PROJECTION			LBTEK			
	NAME	DATE				
DRAWN	LZHOU	MAR./15th/24	RIGHT ANGLE PRISM L x H=12.5 mm x 12.5 mm, UNCOATED			
APPROVAL	WCHENG	MAR./15th/24	MATERIAL	WEIGHT	SCALE	REV
FOR INFORMATION ONLY NOT FOR MANUFACTURING PURPOSES			UVFS	2.15 g	5:1	B